CRMGGH0401B

N-Channel 40V, 1.6mΩ Typ. Power MOSFET

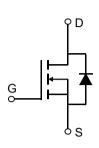
Description

Features

• 40V, 140A

$$R_{DS(ON)}$$
 Typ = 1.6m Ω @ V_{GS} = 10V

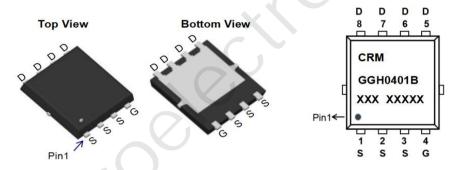
- Advanced Split Gate Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- 100% UIS TESTED!
- 100% ΔVds TESTED!





Application

- Load Switch
- PWM Application
- Power Management



Marking and Pin Assignment

Initial Version: 1.0

Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMGGH0401B	CRMGGH0401B	PDFN5x6-8L	TAPING	13"	5000	50000

Absolute Maximum Ratings (@ $T_J = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter		Value	Units
V_{DS}	Drain-to-Source Voltage		40	V
V_{GS}	Gate-to-Source Voltage		±20	V
	Continuous Drain Current	T _C = 25°C	140	А
I _D		T _C = 100°C	84	А
I _{DM}	Pulsed Drain Current (1)		560	Α
E _{AS}	Single Pulsed Avalanche Energy (2)		233	mJ
P_{D}	Power Dissipation	T _C = 25°C	70	W
$R_{ heta JC}$	Thermal Resistance, Junction to Case		1.78	°C/W
T_J,T_STG	Junction & Storage Temperature Range		-55 to 150	°C



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Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Chara	acteristics					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 40V, V _{GS} = 0V	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Chara	acteristics				6	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	2.6	3.5	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽³⁾	V _{GS} = 10V, I _D = 30A	-	1.6	2.1	mΩ
Dynamic	Characteristics					
C _{iss}	Input Capacitance		- /	3543	-	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V,$ f = 1MHz	-	1447	-	pF
C_{rss}	Reverse Transfer Capacitance	1 - 1101112	X -\	29	-	pF
Q _g	Total Gate Charge			70	-	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 20V, I_{D} = 30A$	U .	10	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} - 20V, I _D - 30A	-	9	-	nC
Switchin	g Characteristics					
t _{d(on)}	Turn-On DelayTime		-	900	-	ns
t_r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 20V$	-	20	-	ns
$t_{\text{d(off)}}$	Turn-Off DelayTime	I_D = 30A, R_{GEN} = 3Ω	-	72	-	ns
t_f	Turn-Off Fall Time		-	33	-	ns
Drain-So	urce Diode Characteristics and M	Max Ratings				
I _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	140	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	560	Α
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 30A$	-	-	1.2	V
trr	Body Diode Reverse Recovery Time	1 - 204 4:/4+ - 4004/:	-	30	-	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 20A$, di/dt = 100A/us	-	109	-	nC

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

^{2.} E_{AS} condition: Starting T_J=25°C, V_{DD}=20V, V_G=10V, R_G=25ohm, L=0.5mH, I_{AS}=30.5A

^{3.} Pulse Test: Pulse Width $\!\!\leqslant\! 300\mu s,$ Duty Cycle $\!\!\leqslant\! 0.5\%.$

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Test Circuit

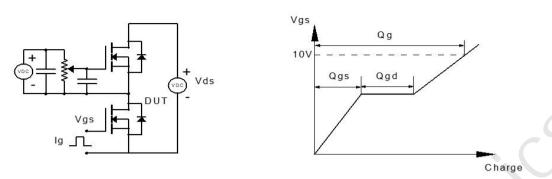


Figure 1: Gate Charge Test Circuit & Waveform

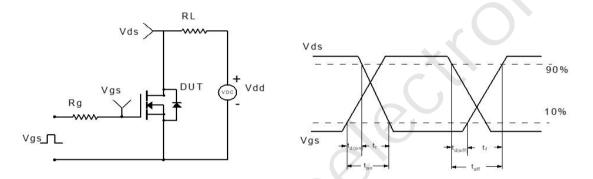


Figure 2: Resistive Switching Test Circuit & Waveform

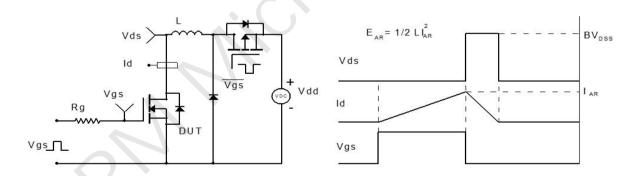


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

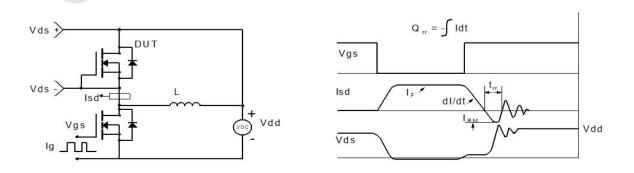
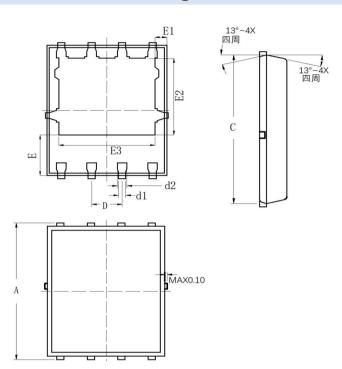


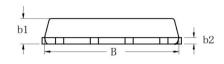
Figure 4: Diode Recovery Test Circuit & Waveform

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Package Mechanical Data(PDFN5x6-8L)





	COMMON DIM	IENSION (MM)	-6	
PKG	PDFN 5×6-8L			
SYMBOL	MIN	TYP	MAX	
А	6.000	6.100	6.200	
В	4.875	4.900	4.925	
b1	0.975	1.000	1.025	
b2	0.246	0.254	0.262	
С	5.775	5.800	5.825	
D	1.245	1.270	1.295	
d1	0.275	0.300	0.325	
d2	0.375	0.400	0.425	
E	1.725	1.775	1.825	
E1	0.395	0.445	0.495	
E2	3.425	3.475	3.525	
E3	3.960	4.010	4.060	

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